

## Work proposal

# TID tests using proton beams

Assessing the radiation hardness of LGADs in high-dose limits

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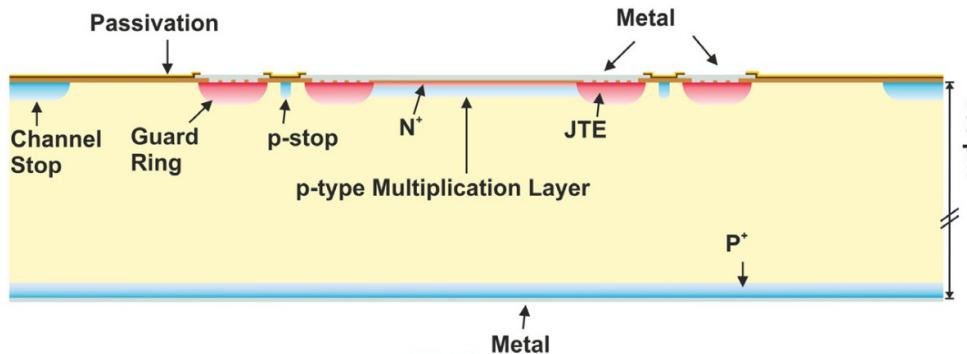
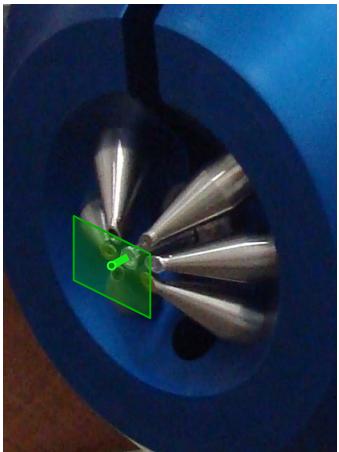
*Universidade de São Paulo, Brazil*



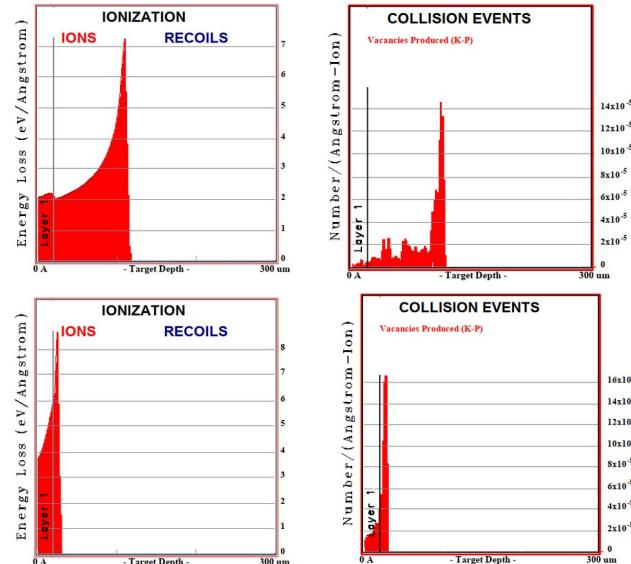
High Energy Physics and Instrumentation Center at USP

- Test radiation hardness of LGADs in high-dose limits
  - *With lateral resolution*
  - *With in-depth resolution*
- Take advantage of the LAMFI-USP infrastructure

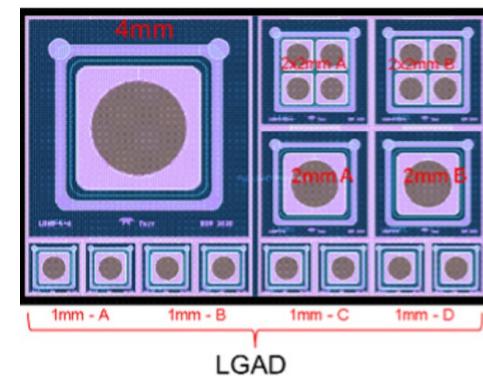
# Tests with proton beams



3.4 MeV

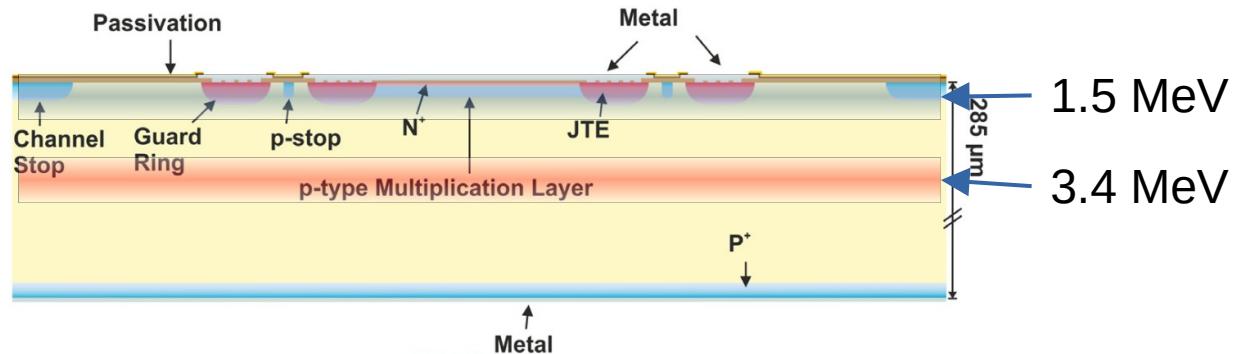
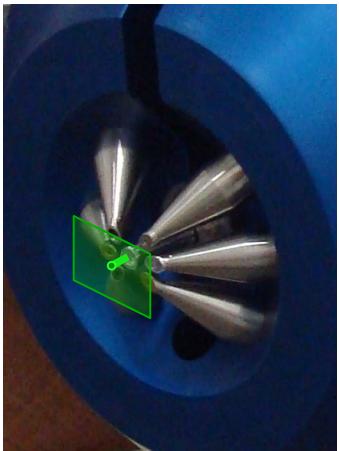


1.5 MeV

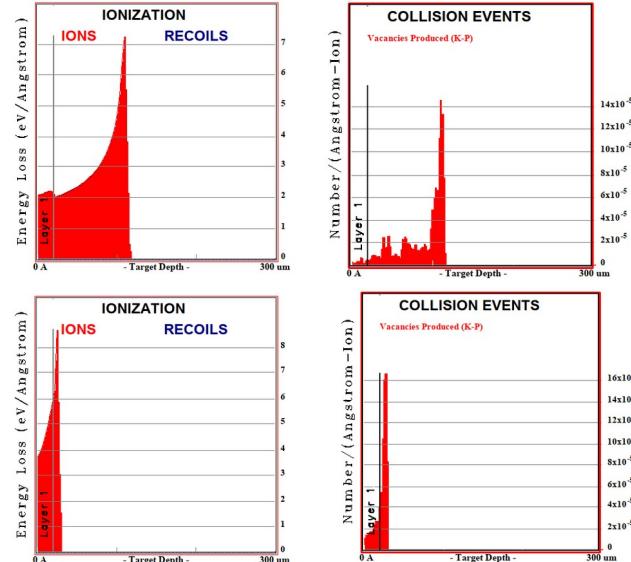


- 1,0 mm
- 200  $\mu m$
- 10  $\mu m$

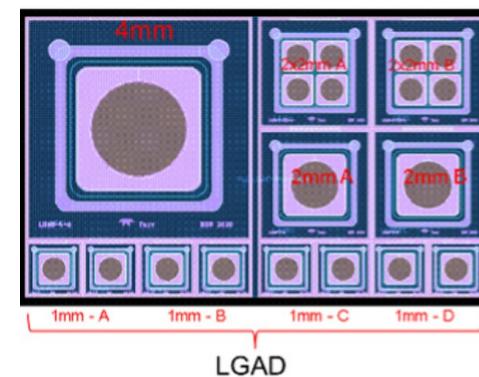
# Tests with proton beams



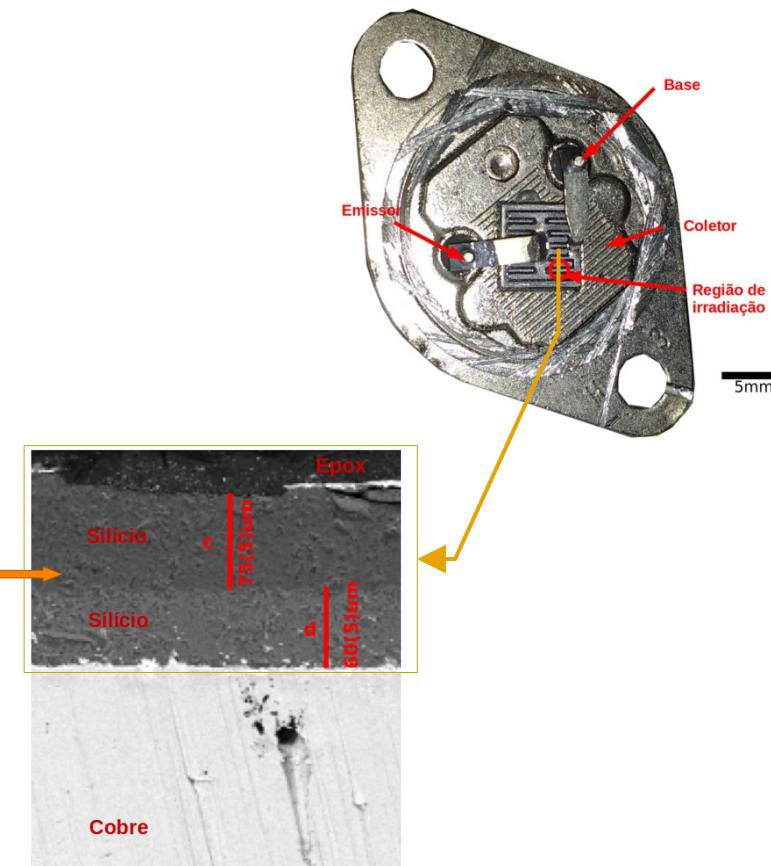
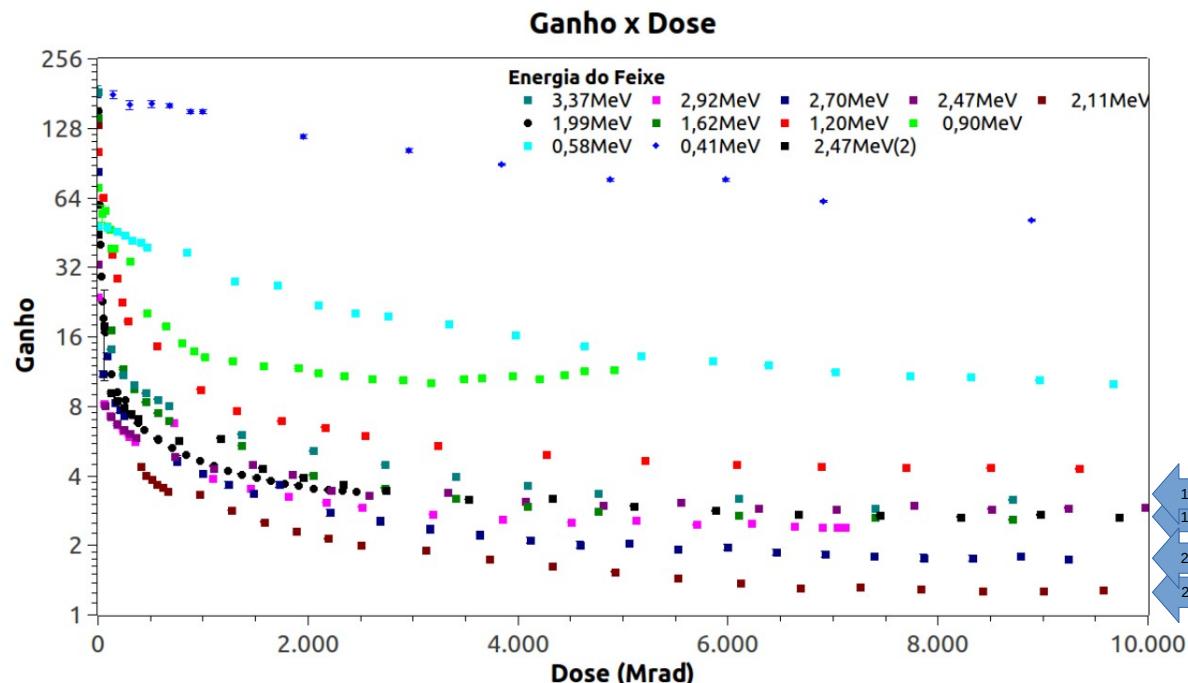
3.4 MeV



1.5 MeV



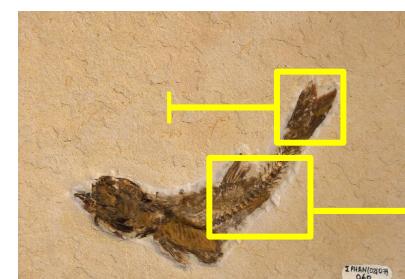
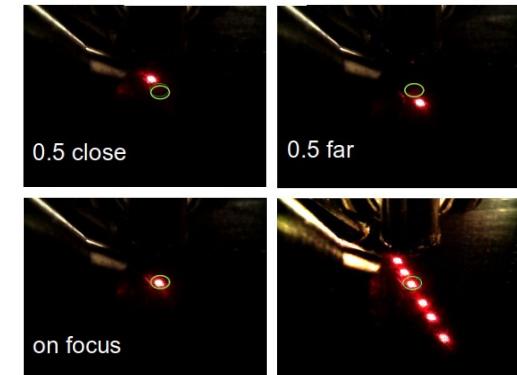
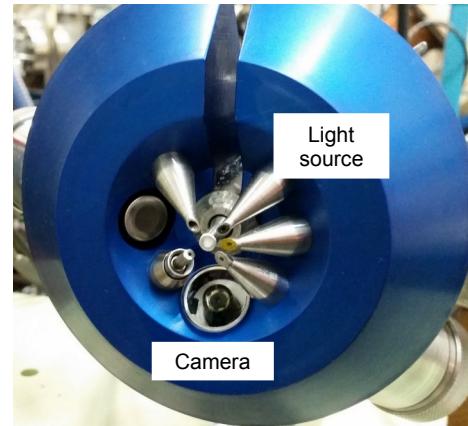
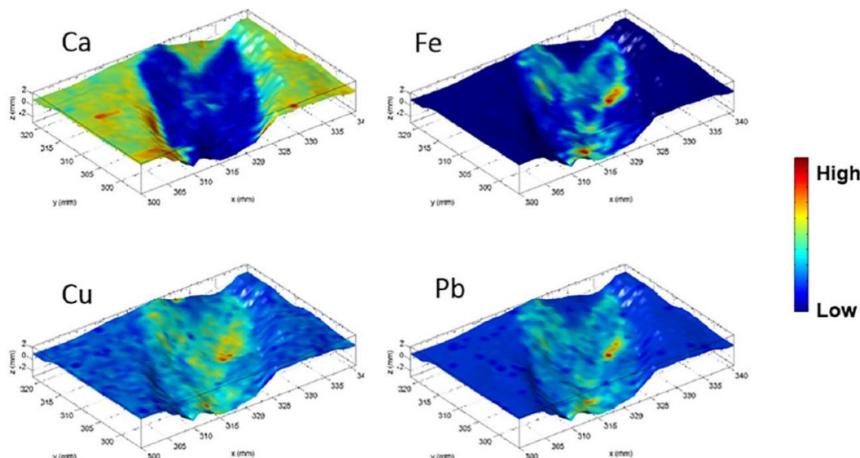
# Previous experience (example)



AGUIRRE, Fernando Rodrigues. Estudo sobre distribuição de cargas em semicondutores sujeitos a radiação ionizante. 2017. Dissertação (Mestrado em Física) - Instituto de Física, Universidade de São Paulo, São Paulo, 2017. doi:10.11606/D.43.2017.tde-13032017-113040. Acesso em: 2023-03-03.

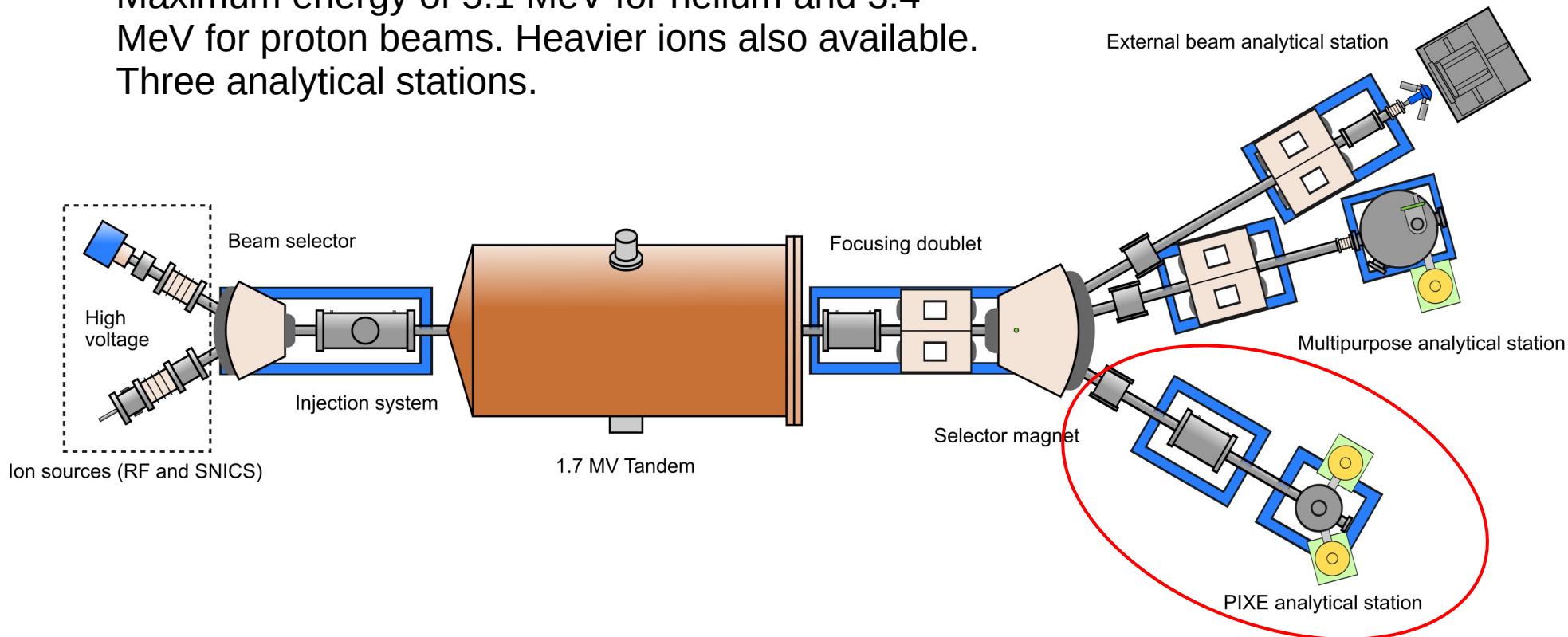
# Experimental setup

- Features a machine vision system to correct for sample irregularities
  - Large areas implies sample irregularities
  - Avoid artifacts in PIXE maps by introducing some level of condition reproducibility



# The project of a micro probe

Maximum energy of 5.1 MeV for helium and 3.4 MeV for proton beams. Heavier ions also available.  
Three analytical stations.



# Potentialities

Nuclear Instruments and Methods in Physics Research B 488 (2021) 50–63

Contents lists available at ScienceDirect

Nuclear Inst. and Methods in Physics Research, B

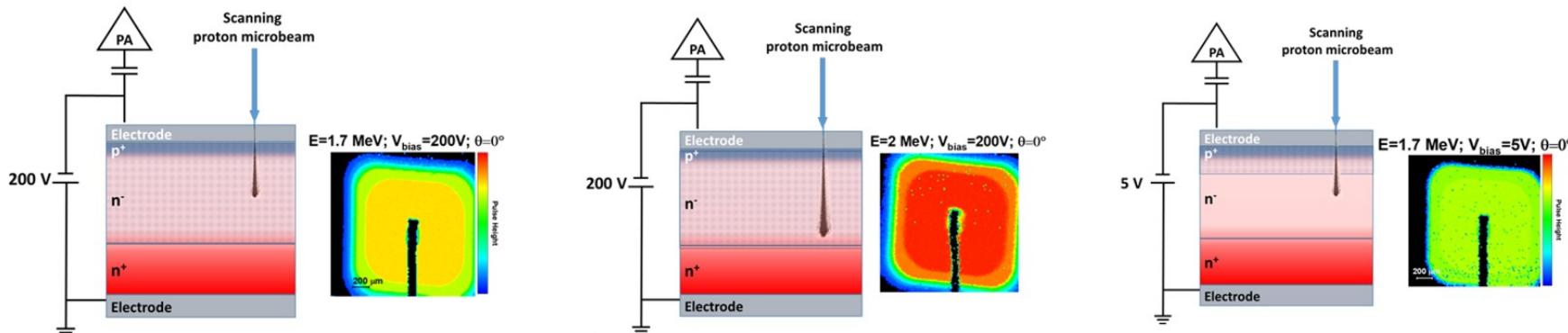
journal homepage: [www.elsevier.com/locate/nimb](http://www.elsevier.com/locate/nimb)

Check for updates.

Polychromatic angle resolved IBIC analysis of silicon power diodes

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- 1 M.Sc. testing TID in the external beam setup
  - *Lateral resolution of 1,0 mm and 200 µm*
  - *Depth resolution of ~10 µm*
- 1 PhD testing IBIC in the new micro-probe
  - *Lateral resolution of ~10 µm (?)*
  - *Depth resolution of ~10 µm*
- **Needs:** Support with the electronics and system automation